

PROCEEDINGS OF SPIE

Optical Modelling and Design

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Editors

13–15 April 2010
Brussels, Belgium

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Published by
SPIE

Volume 7717

Proceedings of SPIE, 0277-786X, v. 7717

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

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Please use the following format to cite material from this book:

Author(s), "Title of Paper," in *Optical Modelling and Design*, edited by Frank Wyrowski, John T. Sheridan, Jani Tervo, Youri Meuret, Proceedings of SPIE Vol. 7717 (SPIE, Bellingham, WA, 2010) Article CID Number.

ISSN 0277-786X
ISBN 9780819481900

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA
Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445
SPIE.org

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Printed in the United States of America.

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